Search Notes



Application/Control No.

Applicant(s)/Patent Under Reexamination

99728373

YEE ET AL.

Examiner

Kim, David S

Applicant(s)/Patent Under Reexamination

YEE ET AL.

Notes	Date	Examiner
www.google.com - various combinations of the following terms: bandpass square law device diode low pass filter heterodyne envelope detector foschini greenstein coherent noncoherent garrett	11/05/2005	DSK
jacobsen ask theory optical precision rectifier ieeexplore.ieee.org - various combinations of the following terms: foschini greenstein garrett jacobsen dual-filter fsk influence laser optical ask heterodyne post-detection	11/05/2005	DSK
www.scirus.com - various combinations of the following terms: envelope detector low pass filter rectifiergarrett jacobsen heterodyne theory	11/05/2005	DSK
scholar.google.com - various combinations of the following terms: envelope detector low pass filter heterodyne	11/05/2005	DSK
EAST search - see search history printout	6/26/2006	DSK
www.google.com - various combinations of the following terms: tone in band ttib fsk photodetector square law detector	6/26/2006	DSK, 6/27/06
scholar.google.com - various combinations of the following terms: double sideband demodulator heterodyne polarization diversity dual fsk tone ttib optical combiner adder summer receiver	6/23/2006	DSK, 6/26/06
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Class	SubClass	Date		Examiner
375	320	6/26/2006	DSK	
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